

Chapter 13 Oscillators and mixers

13.2 Microwave oscillators

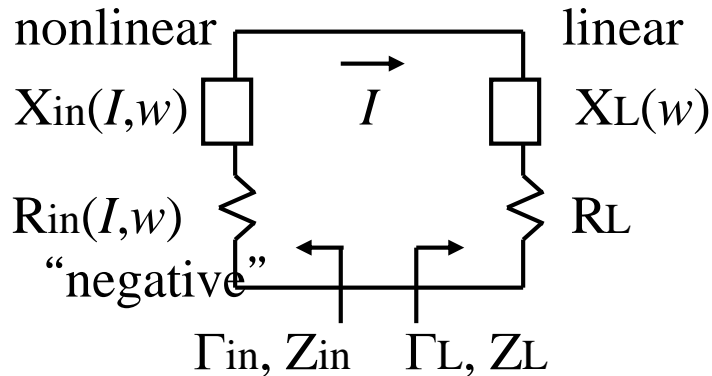
one-port negative resistance oscillator, transistor oscillator,
DRO (dielectric resonator oscillator)

13.5 Mixers

single-ended mixer, balanced mixer, FET mixers

13.2 Microwave oscillators

- one-port negative resistance oscillators



@ steady state

$$\text{KVL} \rightarrow (Z_L + Z_{in})I = 0$$

$$I \neq 0 \rightarrow R_L + R_{in} = 0, X_L + X_{in} = 0$$

$$\text{passive load} \rightarrow R_{in} < 0$$

Discussion

1. oscillator concept

noise \rightarrow circuit unstable $R_{in}(I, w) + RL(w) < 0$

\rightarrow feedback and amplify near w_0

\rightarrow at steady state $R_{in}(I_0, w_0) + RL = 0, X_{in}(I_0, w_0) + XL(w_0) = 0$

\rightarrow oscillation at w_0 with output power $P_o = 1/2 I_o^2 R$

$$2. Z_{in} + Z_L = 0 \rightarrow \Gamma_{in} \Gamma_L = 1$$

$$\therefore \Gamma_L = \frac{Z_L - Z_o}{Z_L + Z_o} = \frac{-Z_{in} - Z_o}{-Z_{in} + Z_o} = \frac{Z_{in} + Z_o}{Z_{in} - Z_o} = \frac{1}{\Gamma_{in}}$$

3. A high-Q tuning circuit enhances the oscillation stability using perturbation analysis

$$Z_T(I, s) \equiv Z_L(s) + Z_{in}(I, s) = 0, s \equiv \alpha + j\omega$$

$$Z_T(I, s) = Z_T(I_o, s_o) + \frac{\partial Z_T}{\partial s} \Big|_{s_o, I_o} \delta s + \frac{\partial Z_T}{\partial I} \Big|_{s_o, I_o} \delta I = 0$$

$$\rightarrow \delta s = \delta\alpha + j\delta\omega = - \frac{\partial Z_T / \partial I}{\partial Z_T / \partial s} \Big|_{s_o, I_o} \delta I = -j \frac{\partial Z_T / \partial I \partial Z_T^* / \partial \omega}{|\partial Z_T / \partial \omega|^2} \Big|_{s_o, I_o} \delta I$$

if $\delta I > 0$ occurs $\rightarrow \delta\alpha < 0$ for a stable oscillation

$$\rightarrow \text{Im} \left\{ \frac{\partial Z_T}{\partial I} \frac{\partial Z_T^*}{\partial \omega} \right\} < 0, \text{ or } \text{Im} \left\{ \frac{\partial(R_T + jX_T)}{\partial I} \frac{\partial(R_T - jX_T)}{\partial \omega} \right\} < 0$$

$$\rightarrow \frac{\partial R_T}{\partial I} \frac{\partial X_T}{\partial \omega} - \frac{\partial X_T}{\partial I} \frac{\partial R_T}{\partial \omega} > 0$$

$$\therefore \frac{\partial R_L}{\partial I} = \frac{\partial X_L}{\partial I} = \frac{\partial R_L}{\partial \omega} = 0 \text{ for a passive load } \rightarrow \frac{\partial R_{in}}{\partial I} \frac{\partial X_T}{\partial \omega} - \frac{\partial X_{in}}{\partial I} \frac{\partial R_{in}}{\partial \omega} > 0$$

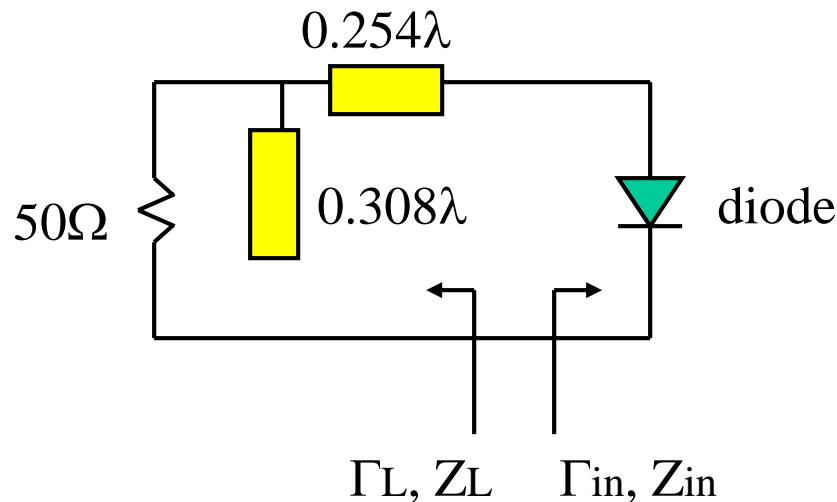
$$\Rightarrow \frac{\partial X_T}{\partial \omega} = \frac{\partial(X_L + X_{in})}{\partial \omega} \gg 0$$

4. oscillator design consideration

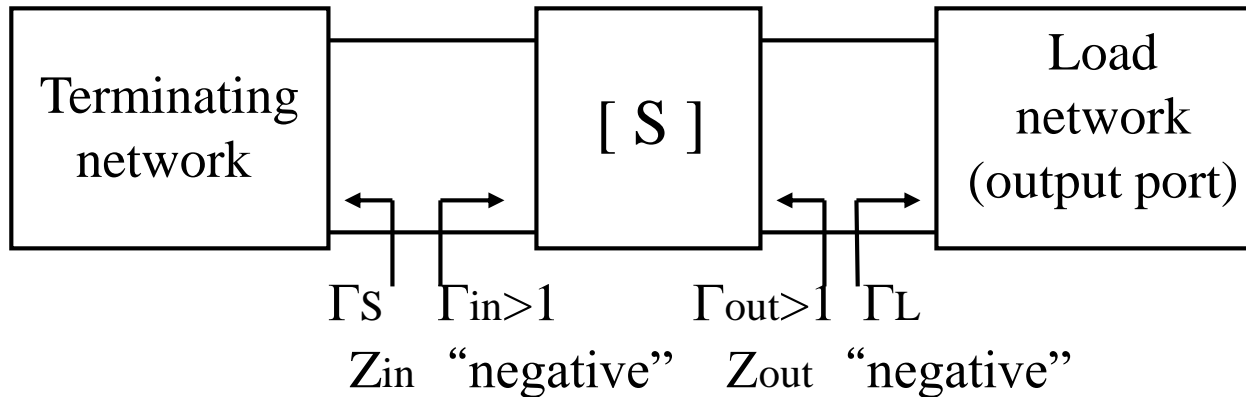
selection of device operation point for stable oscillation and good o/p power, large signal performance, phase noise, frequency pulling,...

5. Ex.13.2 a diode with $\Gamma_{in}=1.25\angle 40^\circ$ @6GHz

$Z_{in}=-44+j123\Omega$, $\rightarrow Z_L=44-j123\Omega$



- transistor oscillator



1. Select transistor configuration to enhance its instability
2. Select Γ_L to produce large value of negative R_{in}
3. Choose $R_S = -R_{in}/3$, $X_S = -X_{in}$

Discussion

1. at steady state $\Gamma_{in} \Gamma_S = 1 \rightarrow \Gamma_{out} \Gamma_L = 1$

$$\frac{1}{\Gamma_S} = \Gamma_{in} = S_{11} + \frac{S_{12} S_{21} \Gamma_L}{1 - S_{22} \Gamma_L} \rightarrow \Gamma_L = \frac{1 - S_{11} \Gamma_S}{S_{22} - \Delta \Gamma_S}, \Delta = S_{11} S_{22} - S_{12} S_{21}$$

$$\Gamma_{out} = S_{22} + \frac{S_{12} S_{21} \Gamma_S}{1 - S_{11} \Gamma_S} = \frac{S_{22} - \Delta \Gamma_S}{1 - S_{11} \Gamma_S} \Rightarrow \Gamma_L \Gamma_{out} = 1$$

2. Ex13.3 FET (CE) @4GHz

$$S_{11} = 0.72 \angle -116^\circ, S_{12} = 0.03 \angle 57^\circ, S_{21} = 2.6 \angle 76^\circ, S_{22} = 0.73 \angle -54^\circ$$

(CG) with a 5nH inductor

$$S'_{11} = 2.18 \angle -35^\circ, S'_{12} = 1.26 \angle 18^\circ, S'_{21} = 2.75 \angle 96^\circ, S'_{22} = 0.52 \angle 155^\circ$$

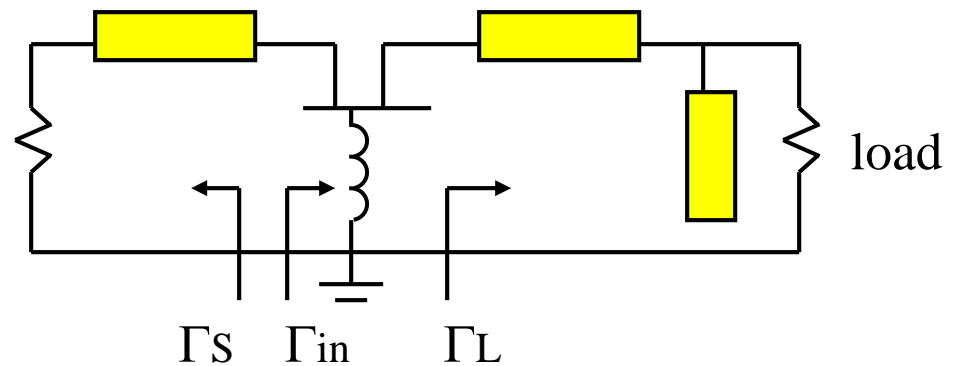
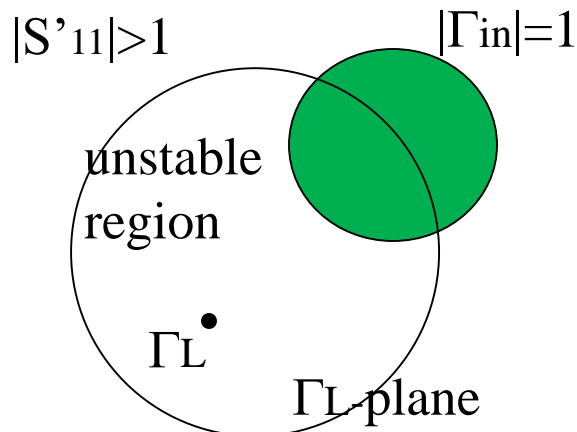
o/p stability circle

$$C_L = 1.08 \angle 33^\circ, R_L = 0.665$$

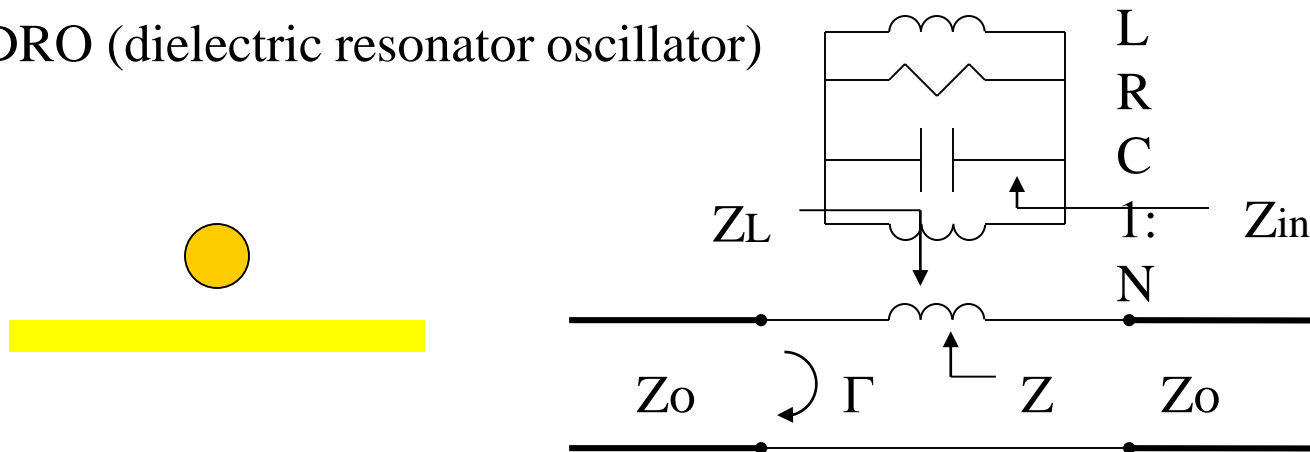
select

$$\Gamma_L = 0.59 \angle -104^\circ \rightarrow \text{a large } \Gamma_{in} = 3.96 \angle -2.4^\circ$$

$$Z_{in} = -84 - j1.9\Omega \rightarrow Z_S = -\frac{R_{in}}{3} - jX_{in} = 28 + j1.9\Omega$$



- DRO (dielectric resonator oscillator)



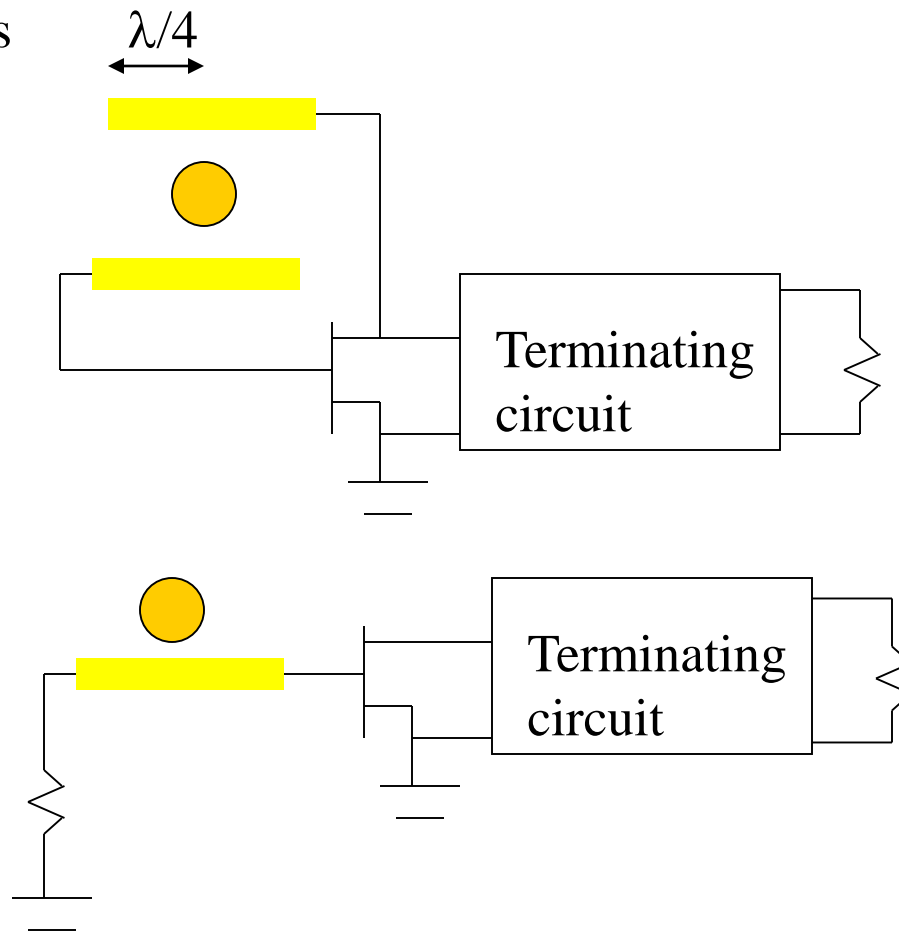
$$Z(w) = N^2 Z_{in}(w) = \frac{N^2 R}{1 + j2Q_U \Delta w / w_o}$$

$$g = \frac{Q_U}{Q_e} = \frac{\frac{R}{w_o L}}{\frac{R_L / N^2}{w_o L}} = \frac{\frac{R}{w_o L}}{\frac{2Z_o / N^2}{w_o L}} = \frac{N^2 R}{2Z_o}$$

$$\Gamma = \frac{Z_o + N^2 R - Z_o}{Z_o + N^2 R + Z_o} = \frac{N^2 R}{2Z_o + N^2 R} = \frac{g}{1 + g} \rightarrow g = \frac{\Gamma}{1 - \Gamma}$$

Discussion

1. DRO examples



2. Ex13.4 BJT @2.4GHz

$$S_{11} = 1.8 \angle 130^\circ, S_{12} = 0.4 \angle 45^\circ, S_{21} = 3.8 \angle 36^\circ, S_{22} = 0.7 \angle -63^\circ$$

DR Qu=1000

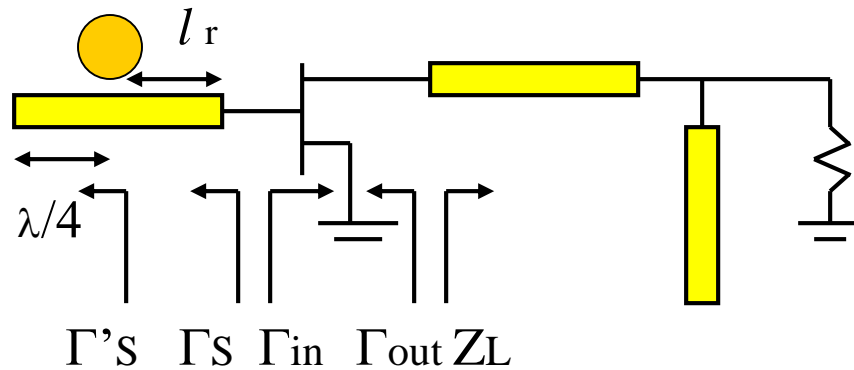
select Γ_S ($\rightarrow S_{11}\Gamma_S \sim 1$) to give a large Γ_{out} $\Gamma_{out} = S_{22} + \frac{S_{12}S_{21}\Gamma_S}{1 - S_{11}\Gamma_S}$

$$\Gamma_S = 0.6 \angle -130^\circ \rightarrow \text{a large } \Gamma_{out} = 10.7 \angle 132^\circ, Z_{out} = -43.7 + j6.1 \Omega$$

$$\rightarrow Z_L = -\frac{R_{out}}{3} - jX_{out} = 14.6 - j6.1 \Omega$$

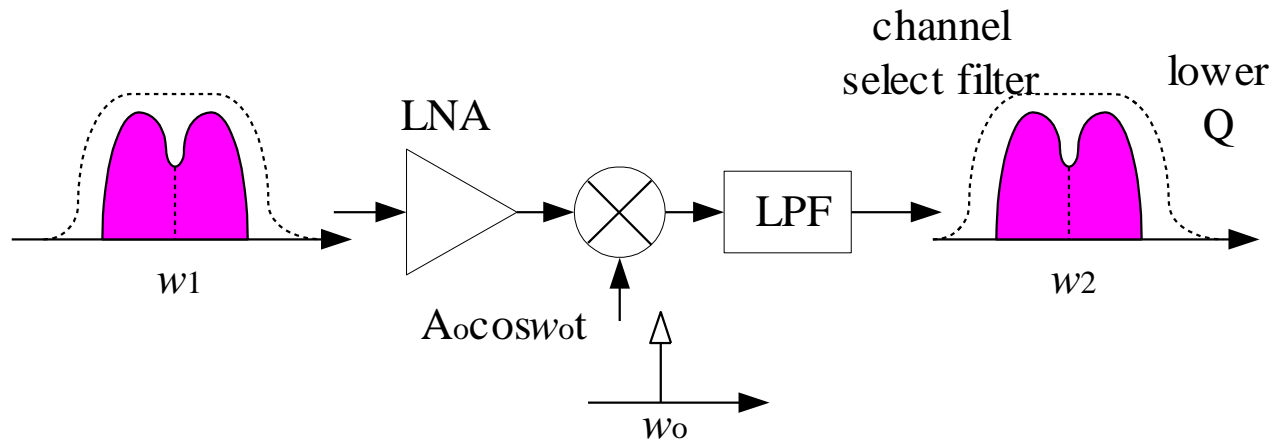
$$\Gamma'_S = \Gamma_S e^{j2\beta l_r} = 0.6 \angle 180^\circ \rightarrow l_r = 0.431\lambda$$

$$Z'_S = 12.5 \Omega \rightarrow g = \frac{N^2 R}{Z_o} = \frac{12.5}{50} = 0.25$$



Discussion

1. heterodyne receiver

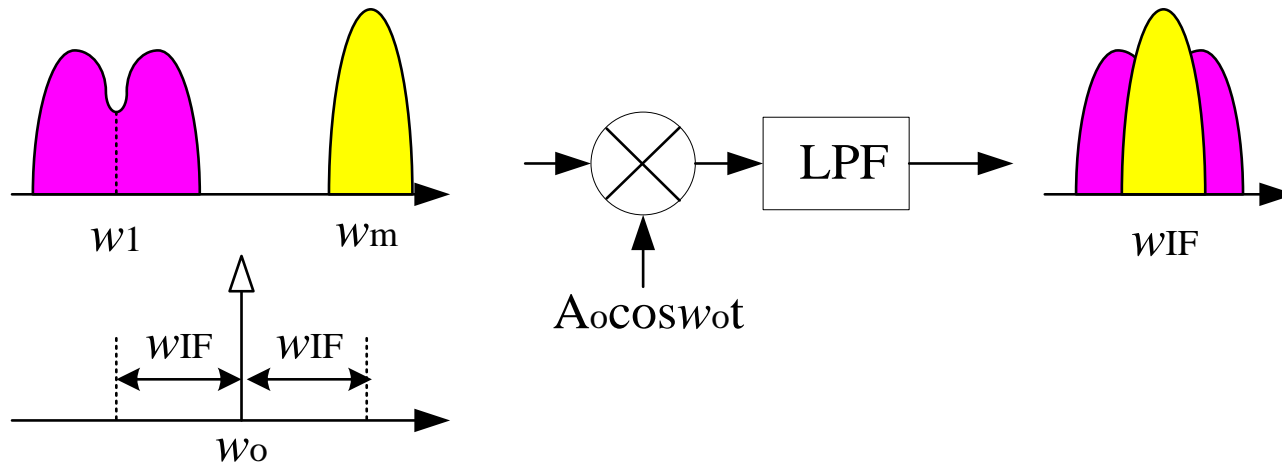


Relax the Q required of the channel-select filter.

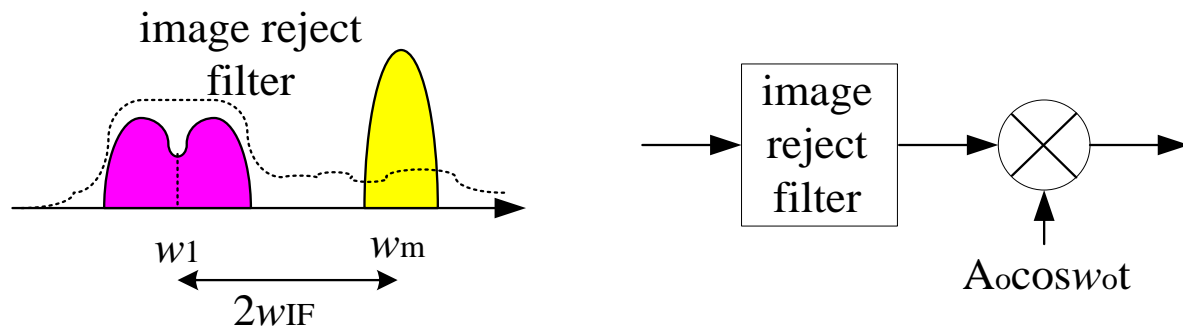
Down-conversion mixer typically has high noise, it's then preceded by a LNA.

2. problem of heterodyne receiver

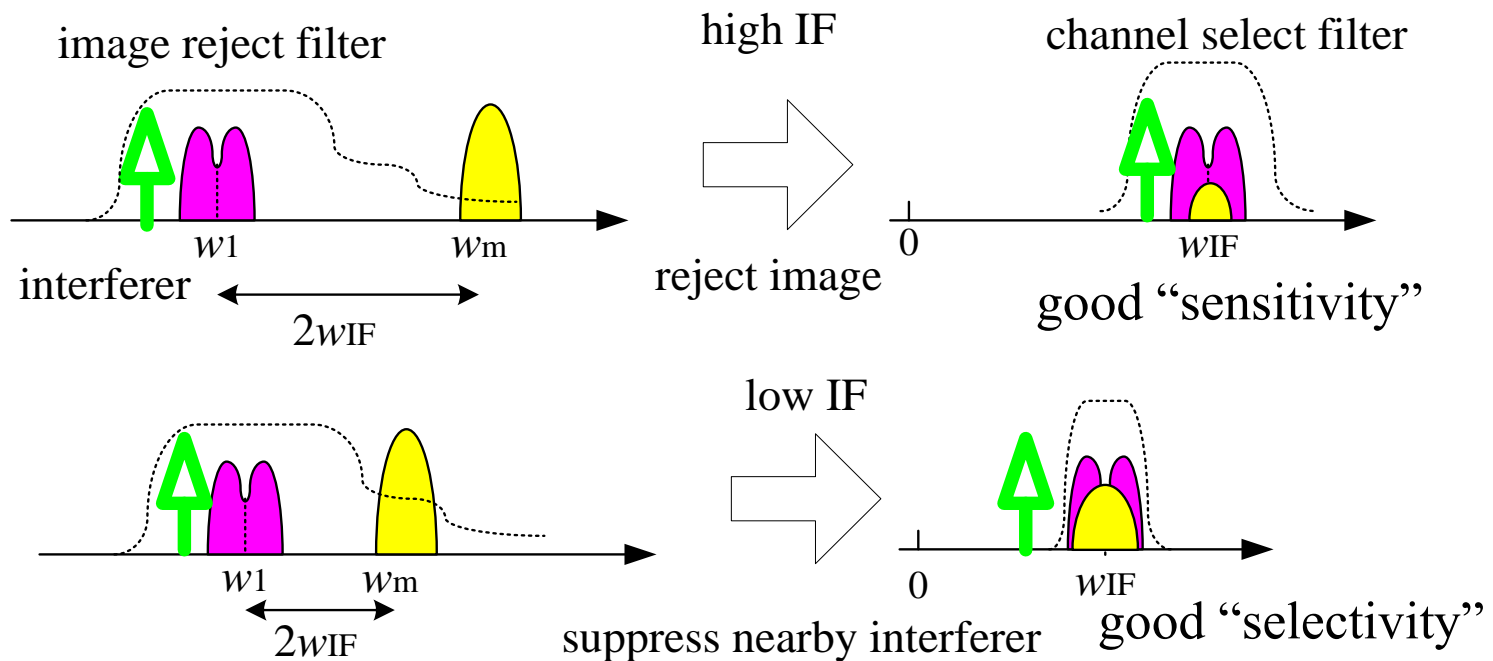
Image signal degrades the receiver sensitivity.



One can use an image-reject filter, but it introduces losses.



3. choice of IF depends on
 the amount of image noise
 the spacing between the desired band and the image
 the loss of image-reject filter
 → trade-off between sensitivity and selectivity

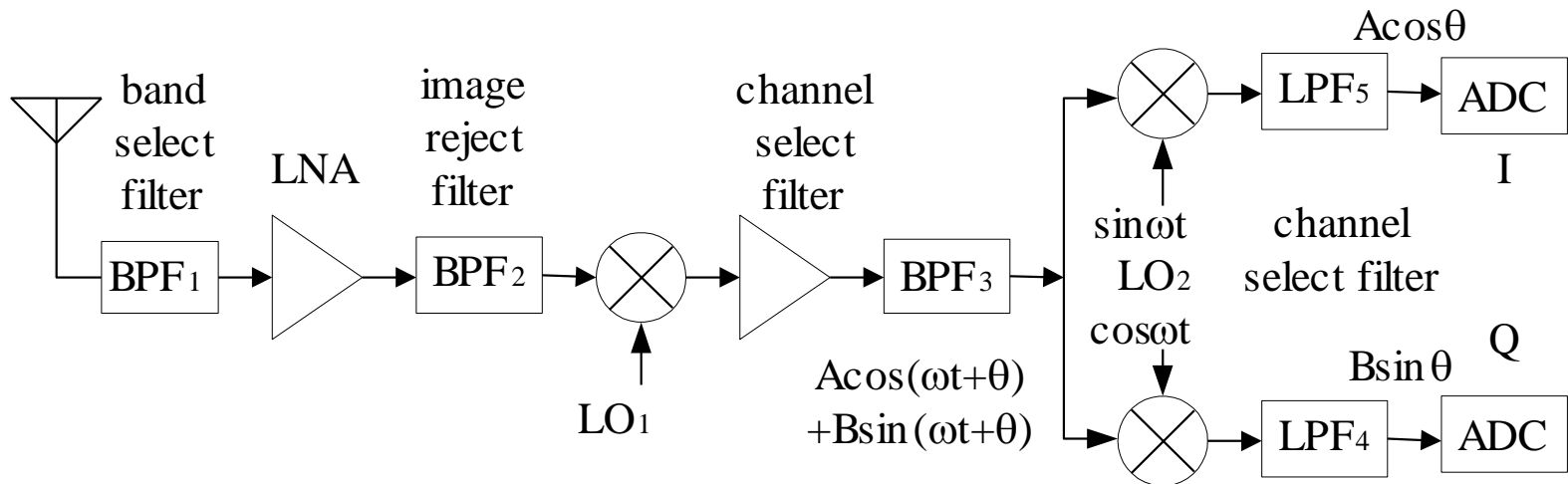


4. dual-IF heterodyne receiver

Partial channel selection at progressively lower center frequencies

Relax the Q required of each filter

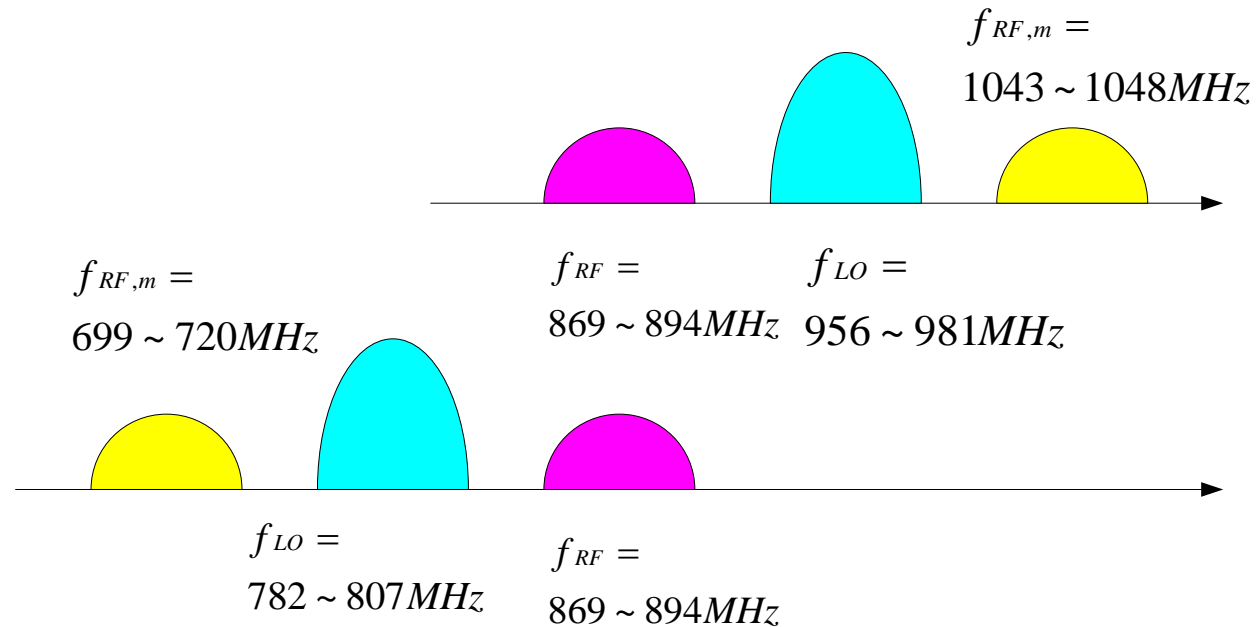
Frequency planning, NF, IP3 and gain calculation are important



5. Ex 13.7 IS-54 digital cell telephone $f_{RF} = 869 \sim 894\text{GHz}$,

$$f_{IF} = 87\text{MHz}$$

$$f_{LO} = f_{RF} \pm f_{IF} = (869 \sim 894) \pm 87 = \begin{cases} 956 \sim 981\text{MHz} \\ 782 \sim 807\text{MHz} \end{cases}$$



6. mixer characteristics

conversion loss $L_c(dB) = 10\log \frac{\text{available RF input power}}{\text{IF output power}}$

DSB noise figure = SSB noise figure / 2

$$\text{SSB } T = (T_o + T_{SSB})G_r + T_o G_i \rightarrow T_{SSB} = \frac{T - T_o(G_r + G_i)}{G_r}$$

$$\text{DSB } T = (T_o + T_{DSB})(G_r + G_i) \rightarrow T_{DSB} = \frac{T - T_o(G_r + G_i)}{G_r + G_i}$$

LO/RF isolation

7. single-ended diode mixer

relative high noise figure, high conversion loss, high-order nonlinearities, no isolation between LO and RF, large output current at LO frequency

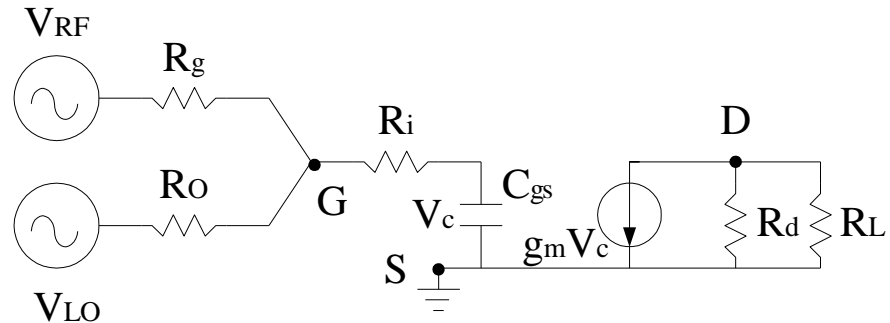
8. single-ended FET mixer

Gate-bias is near the pinch-off region, LO signal then switches FET between high and low transconductance states to give mixing function.

$$v_c^{RF} = V_c^{RF} \cos \omega_{RF} t$$

$$V_c^{RF} = V_{RF} \frac{1/j\omega_{RF} C_{gs}}{Z_g + R_i + 1/j\omega_{RF} C_{gs}}$$

$$= \frac{V_{RF}}{1 + j\omega_{RF} C_{gs} (R_i + Z_g)}$$



$$g_m(t)v_c^{RF}, g_m(t) = g_o + 2 \sum_{n=0}^{\infty} g_n \cos n\omega_o t \rightarrow g_1 V_c^{RF} \cos \omega_{IF} t$$

$$V_D^{IF} = -g_1 V_c^{RF} \frac{R_d Z_L}{R_d + Z_L} = \frac{-g_1 V_{RF}}{1 + j\omega_{RF} C_{gs} (R_i + Z_g)} \frac{R_d Z_L}{R_d + Z_L}$$

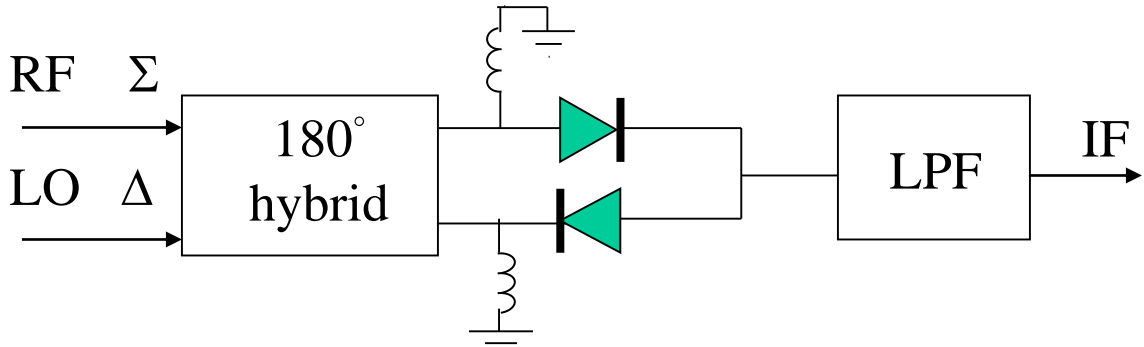
$$G_c = \frac{P_{IF,ava}}{P_{RF,ava}} = \frac{|V_D^{IF}|^2 R_L / |Z_L|^2}{|V_{RF}|^2 / 4R_g} = \frac{4R_g R_L}{|Z_L|^2} \left| \frac{V_D^{IF}}{V_{RF}} \right|^2 \xrightarrow[R_L=R_d]{R_g=R_i} G_c = \frac{g_1^2 R_d}{4\omega_{RF}^2 C_{gs}^2 R_i}$$

9. Ex13.8 A single-ended FET mixer $R_d = 300\Omega, R_i = 10\Omega, C_{gs} = 0.3 pF$

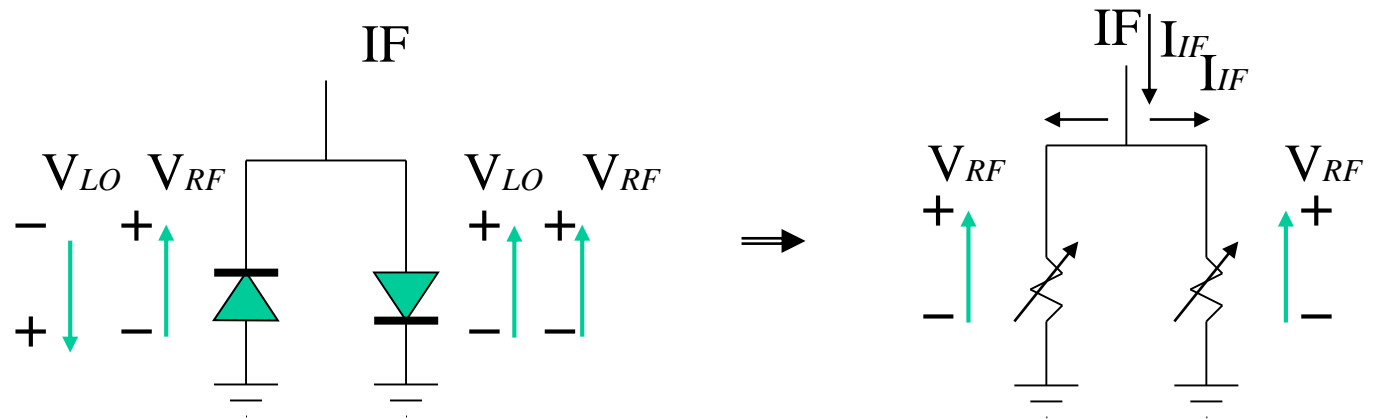
$$g_1 = 10 mS \rightarrow G_c = \frac{g_1^2 R_d}{4\omega_{RF}^2 C_{gs}^2 R_i} = 36.6 = 15.6 dB$$

10. single-balanced mixer

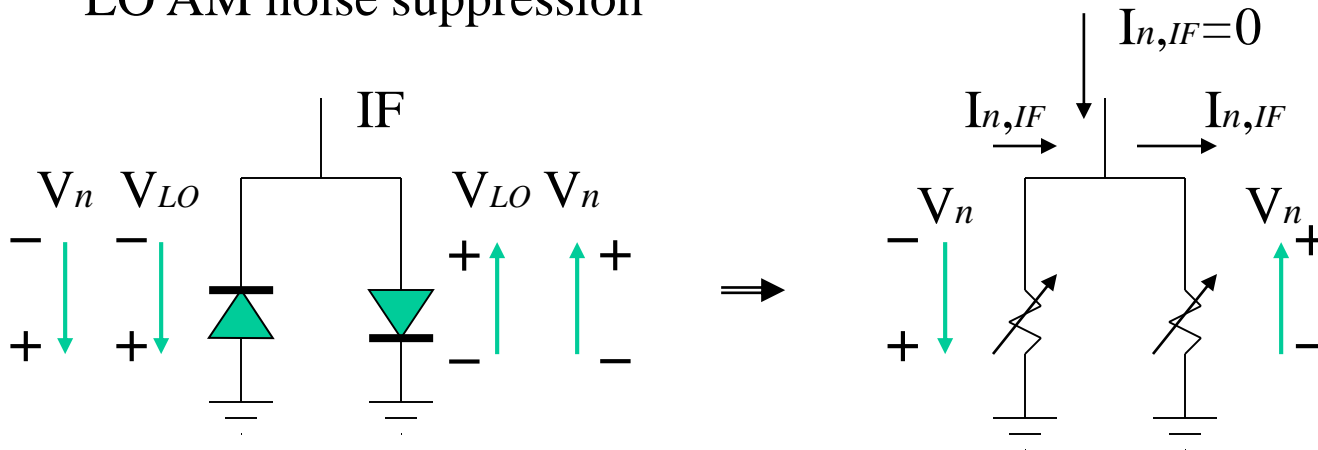
good
RF/LO
isolation



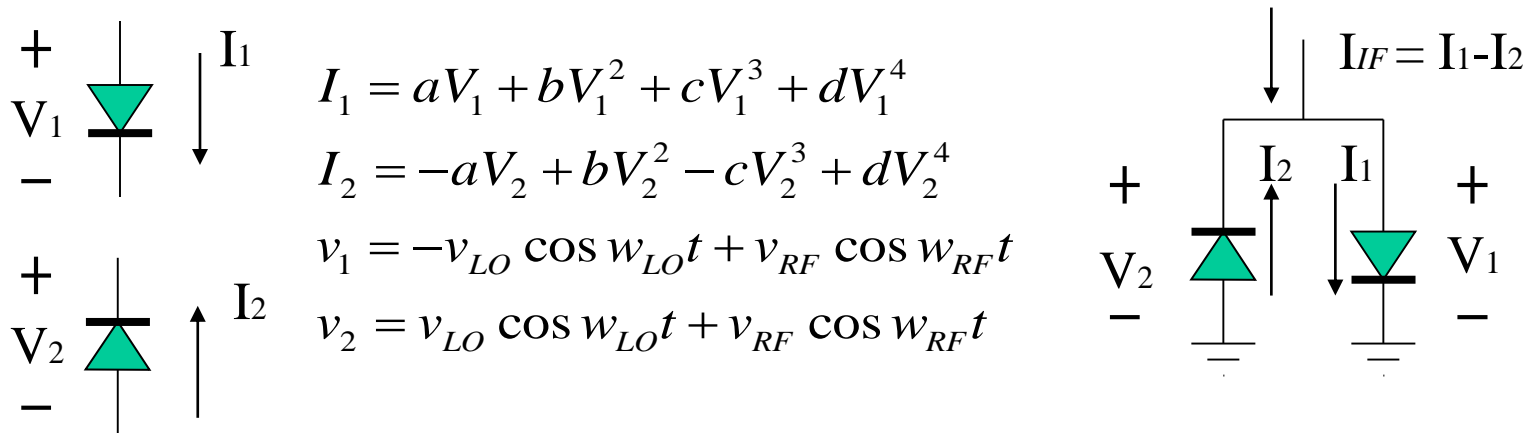
phasor representation



LO AM noise suppression

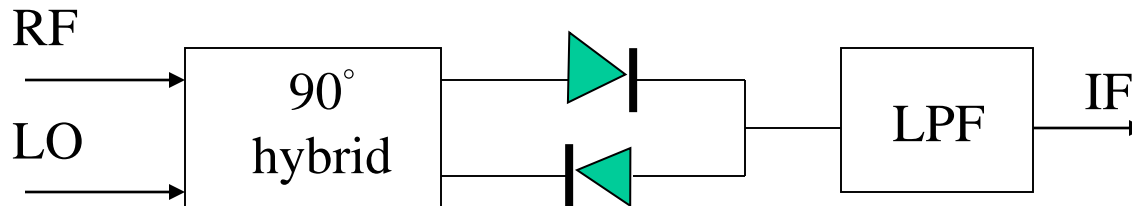


LO even-harmonic suppression

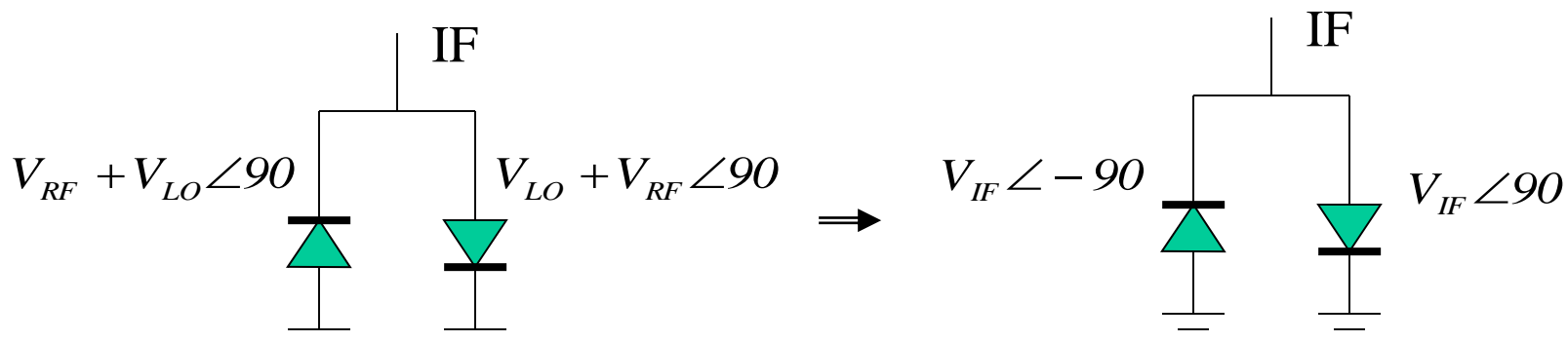


good
RF VSWR

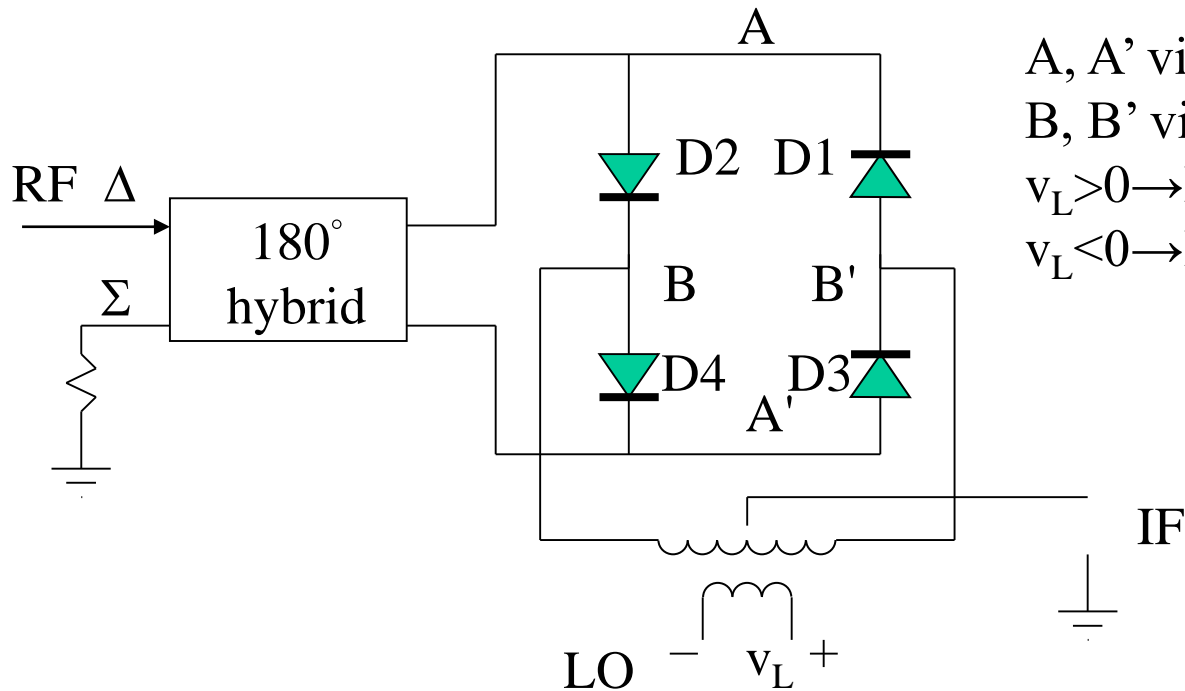
poor RF/LO
isolation



$$\frac{-1}{\sqrt{2}} \begin{bmatrix} 0 & j & 1 & 0 \\ j & 0 & 0 & 1 \\ 1 & 0 & 0 & j \\ 0 & 1 & j & 0 \end{bmatrix} \begin{bmatrix} 1 \\ 0 \\ 0 \\ 0 \end{bmatrix} = \frac{-1}{\sqrt{2}} \begin{bmatrix} 0 \\ j \\ 1 \\ 0 \end{bmatrix}, \quad \begin{bmatrix} 0 & j & 1 & 0 \\ j & 0 & 0 & 1 \\ 1 & 0 & 0 & j \\ 0 & 1 & j & 0 \end{bmatrix} \begin{bmatrix} 0 \\ j\Gamma \\ \Gamma \\ 0 \end{bmatrix} = \begin{bmatrix} 0 \\ 0 \\ 0 \\ j2\Gamma \end{bmatrix}$$



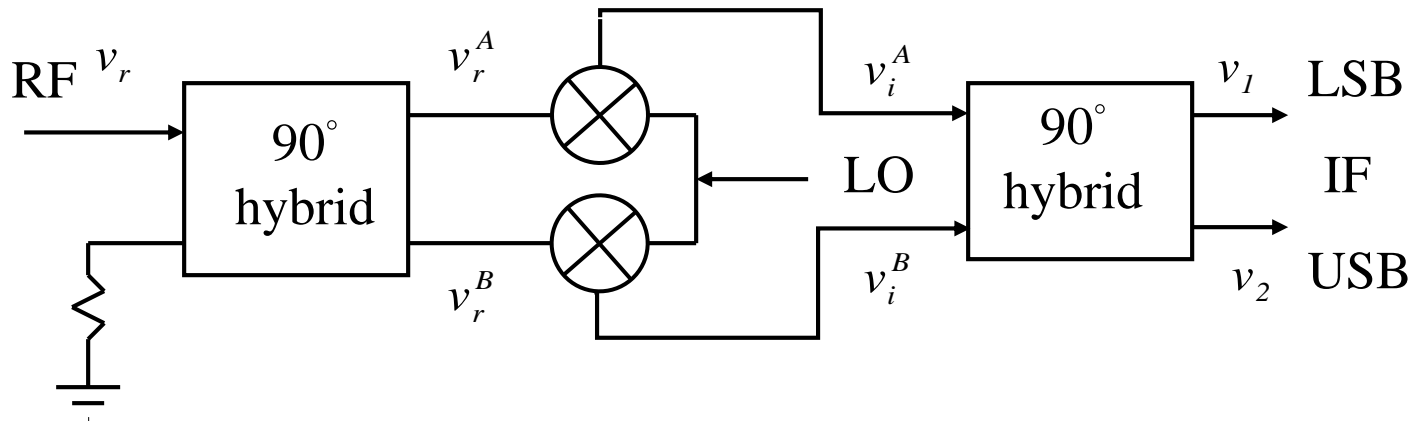
11. double-balanced mixer



A, A' virtual ground for LO
 B, B' virtual ground for RF
 $v_L > 0 \rightarrow D1, D2$ on
 $v_L < 0 \rightarrow D3, D4$ on

good RF/LO isolation
 LO and RF even-harmonics suppressed

12. image-reject mixer



$$v_r = USB + LSB \quad USB = v_u \angle (\omega_o + \omega_i)t \quad LSB = v_L \angle (\omega_o - \omega_i)t$$

$$v_r^A = USB \angle (\omega_o + \omega_i)t - 90 + LSB \angle (\omega_o - \omega_i)t - 90$$

$$v_r^B = USB \angle (\omega_o + \omega_i)t + LSB \angle (\omega_o - \omega_i)t$$

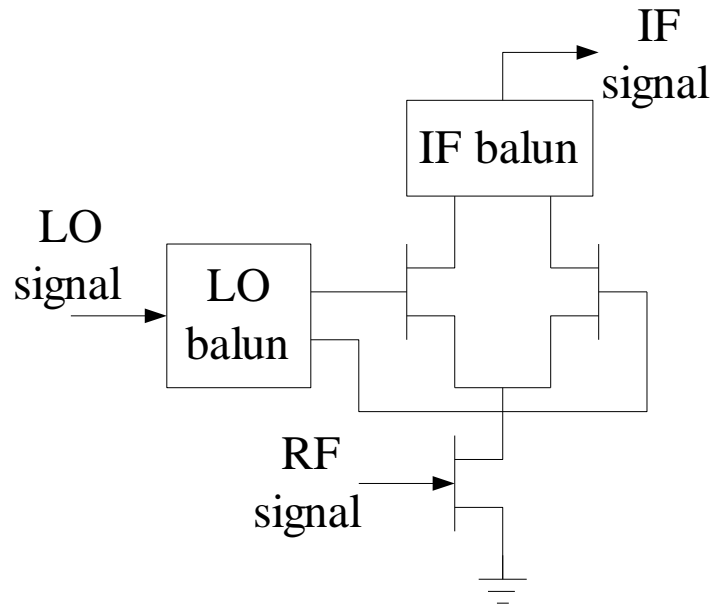
$$v_i^A = USB \angle \omega_i t - 90 + LSB \angle -\omega_i t - 90 = USB \angle \omega_i t - 90 + LSB \angle \omega_i t + 90$$

$$v_i^B = USB \angle \omega_i t + LSB \angle -\omega_i t = USB \angle \omega_i t + LSB \angle \omega_i t$$

$$v_1 = v_i^A \angle -90 + v_i^B = 2LSB \angle \omega_i t$$

$$v_2 = v_i^A + v_i^B \angle -90 = 2USB \angle \omega_i t$$

13. differential mixer



ADS examples: Ch13_prj

Gilbert cell mixer

